Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/670,744	KOBAYASHI ET AL.	
Examiner	Art Unit	
Rosalvnd Keys	1621	

SEARCHED				
Class	Subclass	Date	Examiner	
568	664	4/28/2006	RK	
568	665	4/28/2006	RK	
568	669	4/28/2006	RK	
568	670	4/28/2006	RK	
560	125	4/28/2006	RK	
560	256	4/28/2006	RK	
562	502	4/28/2006	RK	
562	507	4/28/2006	RK	
562	510	4/28/2006	RK	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
568 664		4/28/2006	RK
568	665, 669	4/28/2006	RK
568	670	4/28/2006	RK
560/125, 256 562/502, 507, 510		4/28/2006	RK

SEARCH NOT (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
EAST (see attached printout, which includes an inteference search)	4/28/2006	RK
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Search Notes				

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/670,744	KOBAYASHI ET AL.	
Examiner	Art Unit	
Rosalvnd Kevs	1621	

	SEARCHED				
Class	Subclass	Date	Examiner		
560	125	6/25/2005	RK		
560	256	6/25/2005	RK .		
562	502	6/25/2005	RK		
562	507	6/25/2005	RK		
562	510	6/25/2005	RK		
568	665	6/25/2005	RK		
568	669	6/25/2005	RK		
568	664	1/25/2005	er		

INTERFERENCE SEARCHED			
Class	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST, including inventor search, (see printout)	6/25/2005	RK
STN (see printout)	7/18/2005	RK
STN (see printout)	7/19/2005	RK
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Application No.	Applicant(s)	
10/670,744	KOBAYASHI ET AL.	
Examiner	Art Unit	
Rosalvnd Kevs	1621	

SEARCHED				
Class	Class Subclass Date			
568	664	12/11/2004	Ru	
568	665	12/11/2004		
568	669	12/11/2004		
560	125	12/11/2004		
560	256	12/11/2004		
562	502	12/11/2004		
562	507	12/11/2004	V	
562	510	12/11/2004	KU	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
STN (see printout)		11/24/2004	RK
EAST (see printout)		12/11/2004	RK
STN (see printouts)		12/11/2004	RK
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